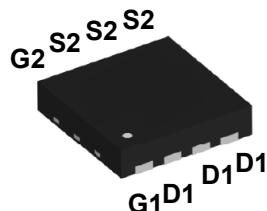
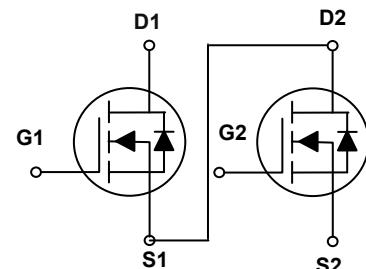
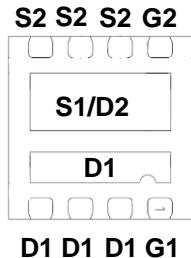


Main Product Characteristics

V _{DSS}	30V
R _{DS(on)(max.)}	10.5mΩ
I _D	19.5A



DFN3X3



Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



Description

The SSFN3010H utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supply and a wide variety of other applications.

Absolute Maximum Ratings (T_C=25°C unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±20	V
Drain Current-Continuous (T _C =25°C)	I _D	19.5	A
Drain Current-Continuous (T _C =100°C)		12.3	
Drain Current-Continuous (T _A =25°C)		10.8	
Drain Current-Continuous (T _A =100°C)		6.8	
Drain Current-Pulsed ¹	I _{DM}	78	A
Single Pulse Avalanche Energy ²	E _{AS}	13	mJ
Single Pulse Avalanche Current ²	I _{AS}	16	A
Power Dissipation (T _C =25°C)	P _D	27	W
Power Dissipation-Derate above 25°C		0.01	W/°C
Thermal Resistance, Junction-to-Ambient	R _{θJA}	62	°C/W
Thermal Resistance, Junction-to-Case	R _{θJC}	4.6	°C/W
Operating Junction Temperature Range	T _J	-55 To +150	°C
Storage Temperature Range	T _{STG}	-55 To +150	°C

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
On/Off Characteristics							
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	30	-	-	V	
BV_{DSS} Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Reference to 25°C , $I_{\text{D}}=1\text{mA}$	-	0.04	-	$\text{V}/^\circ\text{C}$	
Drain-Source Leakage Current	$I_{\text{DS}(\text{SS})}$	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}, T_J=25^\circ\text{C}$	-	-	1	μA	
		$V_{\text{DS}}=24\text{V}, V_{\text{GS}}=0\text{V}, T_J=125^\circ\text{C}$	-	-	10	μA	
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA	
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=10\text{A}$	-	8.4	10.5	$\text{m}\Omega$	
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=5\text{A}$	-	10.8	14		
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250\mu\text{A}$	1.2	1.6	2.5	V	
$V_{\text{GS}(\text{th})}$ Temperature Coefficient	$\Delta V_{\text{GS}(\text{th})}$		-	-4	-	$\text{mV}/^\circ\text{C}$	
Forward Transconductance	g_{fs}	$V_{\text{DS}}=5\text{V}, I_{\text{D}}=5\text{A}$	-	12	-	S	
Dynamic and Switching Characteristics							
Total Gate Charge ^{3,4}	Q_g	$V_{\text{DS}}=15\text{V}, I_{\text{D}}=5\text{A}$ $V_{\text{GS}}=10\text{V}$	-	15.6	31	nC	
Gate-Source Charge ^{3,4}	Q_{gs}		-	2.3	5		
Gate-Drain Charge ^{3,4}	Q_{gd}		-	3	6		
Turn-On Delay Time ^{3,4}	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=15\text{V}, R_{\text{G}}=6\Omega$ $V_{\text{GS}}=10\text{V}, I_{\text{D}}=1\text{A}$	-	3.8	7	nS	
Rise Time ^{3,4}	t_r		-	10	19		
Turn-Off Delay Time ^{3,4}	$t_{\text{d}(\text{off})}$		-	22	42		
Fall Time ^{3,4}	t_f		-	6.6	13		
Input Capacitance	C_{iss}		-	620	900		
Output Capacitance	C_{oss}	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, F=1\text{MHz}$	-	85	125	pF	
Reverse Transfer Capacitance	C_{rss}		-	60	90		
Gate Resistance	R_g		$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, F=1\text{MHz}$	-	2.8	5.6	Ω
Drain-Source Diode Characteristics and Maximum Ratings							
Continuous Source Current	I_s	$V_G=V_D=0\text{V},$ Force Current	-	-	19.5	A	
Pulsed Source Current ³	I_{SM}		-	-	39	A	
Diode Forward Voltage ³	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=1\text{A}, T_J=25^\circ\text{C}$	-	-	1	V	

Note:

1. Repetitive rating: Pulsed width limited by maximum junction temperature.
2. $V_{\text{DD}}=25\text{V}, V_{\text{GS}}=10\text{V}, L=0.1\text{mH}, Q1:I_{\text{AS}}=16\text{A}, Q2:I_{\text{AS}}=42\text{A}, R_{\text{G}}=25\Omega$, starting $T_J=25^\circ\text{C}$.
3. Pulse test: pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.
4. Essentially independent of operating temperature.

Typical Electrical and Thermal Characteristic Curves

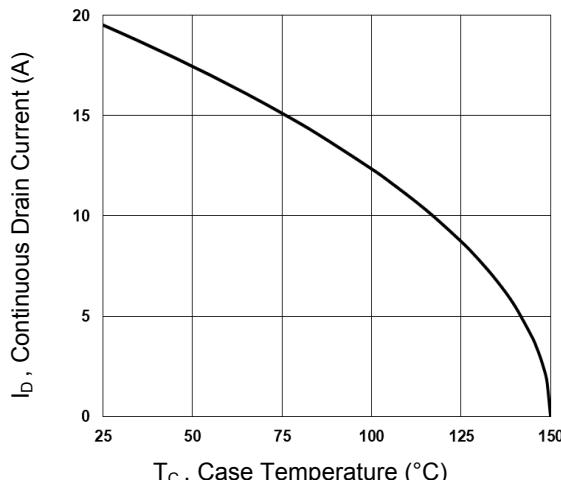


Figure 1. Continuous Drain Current vs. T_c

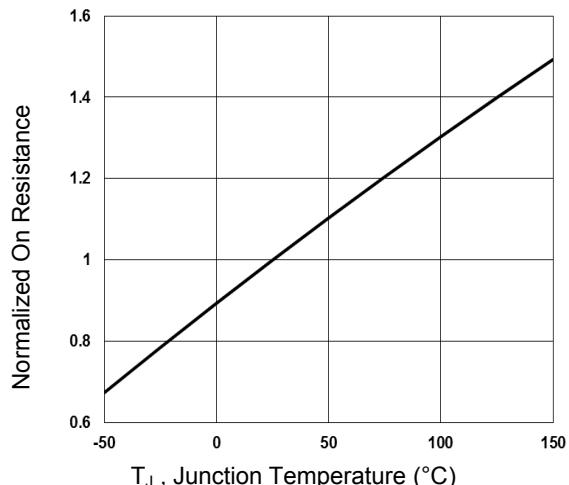


Figure 2. Normalized R_{DSON} vs. T_j

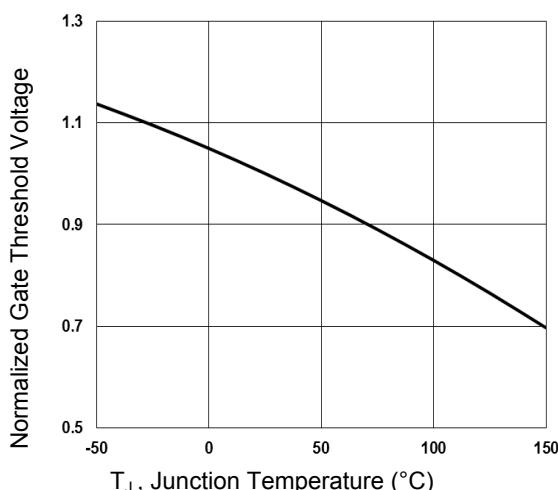


Figure 3. Normalized V_{th} vs. T_j

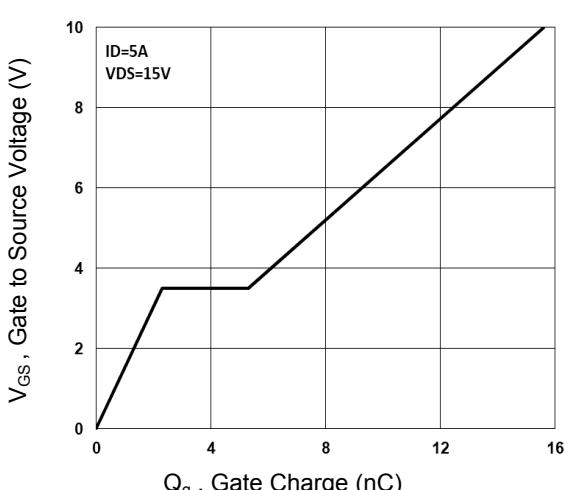


Figure 4. Gate Charge Waveform

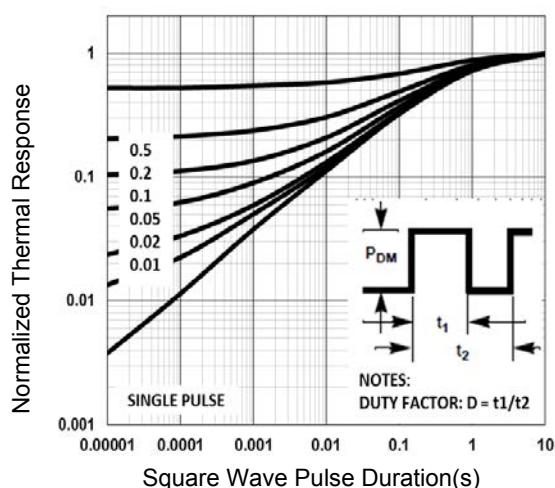


Figure 5. Normalized Transient Impedance

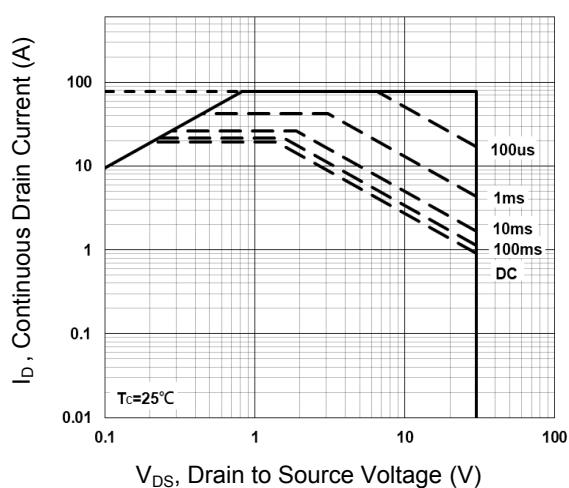


Figure 6. Maximum Safe Operation Area

Typical Electrical and Thermal Characteristic Curves

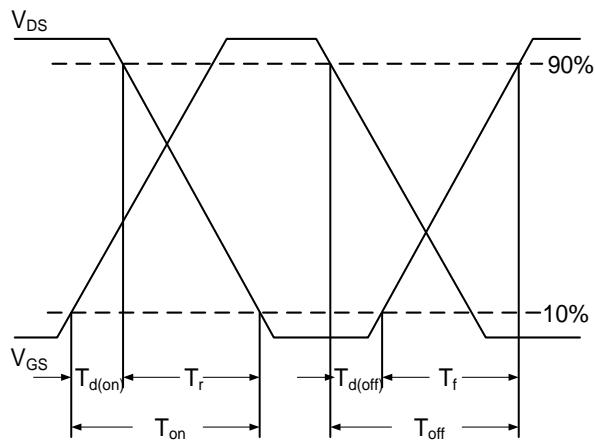


Figure 7. Switching Time Waveform

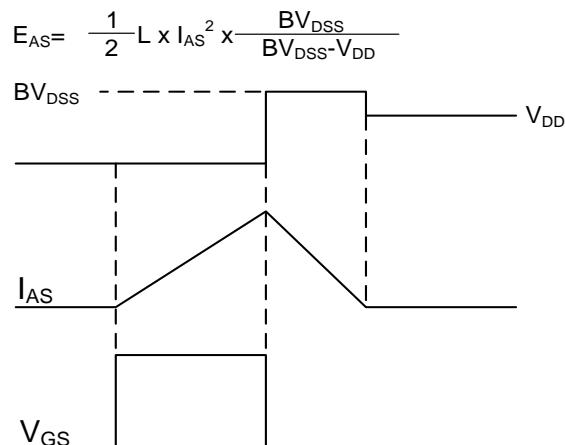
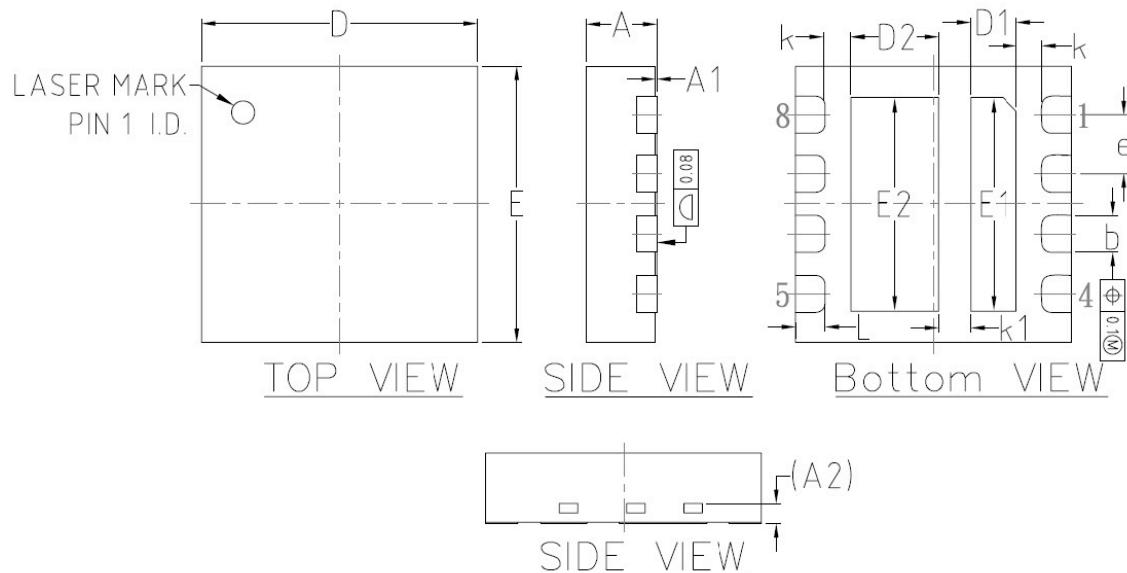


Figure 8. EAS Waveform

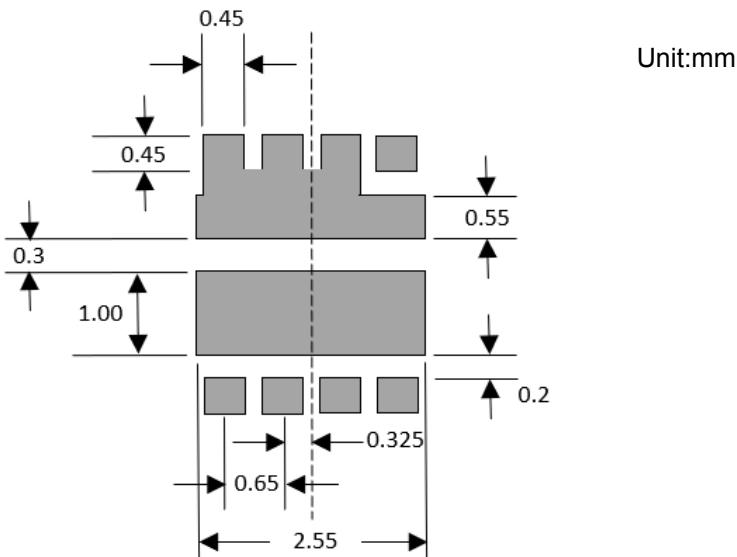
Package Outline Dimensions

DFN3X3 Dual Pin



Symbol	Dimensions In Millimeters		
	Min	Typ	Max
A	0.70	0.75	0.80
A1	0.00	-	0.05
A2	0.20REF		
b	0.35	0.40	0.45
D	2.90	3.00	3.10
D1	0.40	0.50	0.60
D2	0.85	0.95	1.05
E	2.90	3.00	3.10
E1	2.20	2.30	2.40
E2	2.20	2.33	2.45
e	0.55	0.65	0.75
k	0.15	0.28	0.40
k1	0.25	0.35	0.45
L	0.27	-	0.40

Recommended Pad Layout



Order Information

Device	Package	Marking	Carrier	Quantity	HSF Status
SSFN3010H	DFN3x3	DB3010H	Tape & Reel	3000 pcs / Reel	RoHS Compliant